

Attorney Docket: 061063-0317066
Client Reference: OSP-18862

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PATENT APPLICATION of:
AKIRA OKUBO ET AL.

Confirmation Number: 8571

Application No.: 10/544,178

Group Art Unit:

Filed: August 1, 2005

Examiner: TBA

Title: INSPECTION METHOD, MANUFACTURING METHOD OF PIECE FOR
ANALYSIS, ANALYSIS METHOD, ANALYZER, MANUFACTURING METHOD OF SOI
WAFER, AND SOI WAFER

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

TRANSMITTAL OF REPLACEMENT FORMAL DRAWINGS

Attached are the replacement formal drawing(s) for this application. 7
Sheets of Figure(s) 1-8.

Date: April 24, 2006
PILLSBURY WINTHROP SHAW PITTMAN LLP
P.O. Box 10500
McLean, VA 22102
(202) 663.8403
Customer Number: 00909



JEFFREY D. KARCESKI
Registration No. 35914